Si3445DV

P-Channel 1.8V Specified PowerTrench[®] MOSFET

General Description

FAIRCHILD

This P-Channel 1.8V specified MOSFET uses Fairchild's low voltage PowerTrench process. It has been optimized for battery power management applications.

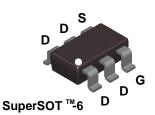
Applications

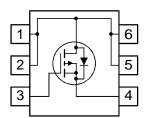
- Battery management
- Load switch
- Battery protection

Features

• -5.5 A, -20 V. $R_{DS(ON)} = 33 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$ $R_{DS(ON)} = 43 \text{ m}\Omega @ V_{GS} = -2.5 \text{ V}$ $R_{DS(ON)} = 60 \text{ m}\Omega @ V_{GS} = -1.8 \text{ V}$

- Fast switching speed.
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$





Absolute Maximum Ratings T_{A=25°C} unless otherwise noted

ain-Source Voltage te-Source Voltage		-20	V
te-Source Voltage			
		±8	V
ain Current – Continuous	(Note 1a)	-5.5	A
- Pulsed		-20	
ximum Power Dissipation	(Note 1a)	1.6	W
	(Note 1b)	0.8	
erating and Storage Junction Tempera	ature Range	-55 to +150	°C
	– Pulsed ximum Power Dissipation	– Pulsed	- Pulsed -20 ximum Power Dissipation (Note 1a) 1.6 (Note 1b) 0.8 0.8

ReJC Thermal Resistance, Junction-to-Case (Note 1) 30 °C/W	$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
	R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	30	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.445	Si3445DV	7"	8mm	3000 units

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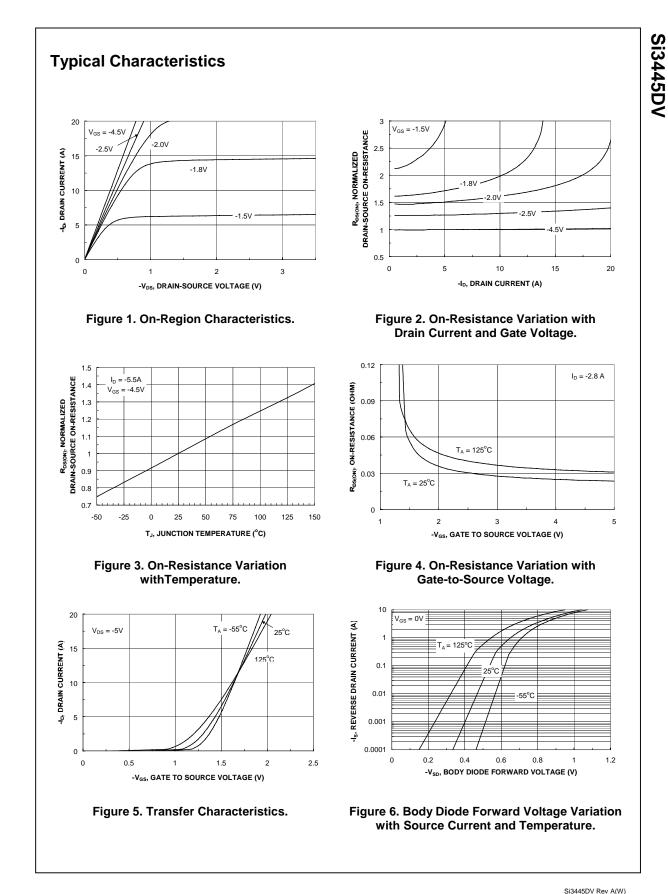
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V, I_D = -250 \mu A$	-20			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$		-12		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -16 V$, $V_{GS} = 0 V$			-1	μA
GSSF	Gate–Body Leakage, Forward	$V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
GSSR	Gate–Body Leakage, Reverse	$V_{GS} = -8 V$ $V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	-0.4	-0.7	-1.5	V
<u>ΔVGS(th)</u> ΔTJ	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$		3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$ \begin{array}{ll} V_{GS} = -4.5 \ V, & I_D = -5.5 \ A \\ V_{GS} = -2.5 \ V, & I_D = -4.8 \ A \\ V_{GS} = -1.8 \ V, & I_D = -4.0 \ A \end{array} $		24 30 42	33 43 60	mΩ
D(on)	On–State Drain Current	$V_{GS} = -4.5 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	-20			А
g fs	Forward Transconductance	$V_{\text{DS}} = -5 \text{ V}, \qquad I_{\text{D}} = -3.5 \text{ A}$		23		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 V$, $V_{GS} = 0 V$,		1926		pF
Coss	Output Capacitance	f = 1.0 MHz		530		pF
Crss	Reverse Transfer Capacitance			185		pF
Switchir	g Characteristics (Note 2)					
d(on)	Turn–On Delay Time	$V_{DD} = -10 V$, $I_D = -1 A$,		13	23	ns
·r	Turn–On Rise Time	$V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		11	20	ns
d(off)	Turn–Off Delay Time	7		90	144	ns
lf	Turn–Off Fall Time			45	72	ns
Qg	Total Gate Charge	$V_{DS} = -10 V$, $I_D = -3.5 A$,		19	30	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -4.5 V$		4		nC
Q _{gd}	Gate-Drain Charge	7		7.5		nC
Drain-Se	ource Diode Characteristics	and Maximum Ratings				
s	Maximum Continuous Drain–Source				-1.3	А
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_{S} = -1.3 A$ (Note 2)		-0.7	-1.2	V

R_{0JA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

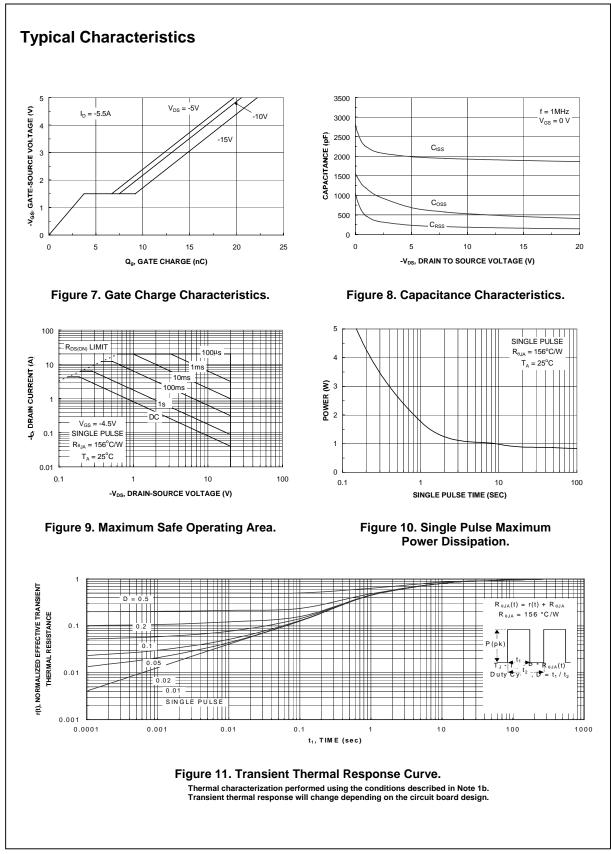
a. 78°C/W when mounted on a 1in^2 pad of 2oz copper on FR-4 board.

b. 156°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width $\leq 300~\mu s,$ Duty Cycle $\leq 2.0\%$



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